

**Notice of References Cited**

Application/Control No.

10/586,058

Applicant(s)/Patent Under

Reexamination

OKUHARA ET AL.

Examiner

STEVEN CERNOCH

Art Unit

3752

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-6,311,901 B1	11-2001	Imoehl et al.	239/533.2
*	B US-2002/0050536 A1	05-2002	Imoehl, William James	239/533.12
*	C US-6,499,668 B2	12-2002	Dallmeyer et al.	239/5
*	D US-6,508,416 B1	01-2003	Mastro et al.	239/585.1
*	E US-2004/0000601 A1	01-2004	Niwa, Yutaka	239/533.2
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N	WO 0111225 A1	02-2001	Japan	Baba, N.	F02M21/02
O					
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	
V	
W	
X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.